

COMPLIANT

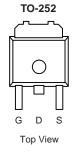
HFD2N90-VB Datasheet

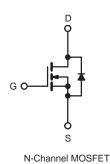
N-Channel 900 V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	900			
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	2.7		
Q _g (Max.) (nC)	200			
Q _{gs} (nC)	24			
Q _{gd} (nC)	110			
Configuration	Single			

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V _{DS}	900	V		
Gate-Source Voltage	V _{GS}	± 20	v		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 \degree C$	I _D	2.0		
Continuous Drain Current	$T_{\rm GS}$ at 10 V $T_{\rm C} = 100 ^{\circ}{\rm C}$		1.5	A	
Pulsed Drain Current ^a	I _{DM}	8.0			
Linear Derating Factor		1.5	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	470	mJ		
Repetitive Avalanche Current ^a	I _{AR}	4.8	A		
Repetitive Avalanche Energy ^a	E _{AR}	19	mJ		
Maximum Power Dissipation	T _C = 25 °C	PD	120	W	
Peak Diode Recovery dV/dt ^c	dV/dt	2.0	V/ns		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	0	
Mounting Torque	6-32 or M3 screw		10	lbf ∙ in	
	0-52 01 WIS SCIEW		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 50 V, starting T_J = 25 °C, L = 23 mH, R_g = 25 Ω , I_{AS} = 7.8 A (see fig. 12). c. I_{SD} \leq 7.8 A, dl/dt \leq 140 A/µs, V_{DD} \leq 600 V, T_J \leq 150 °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

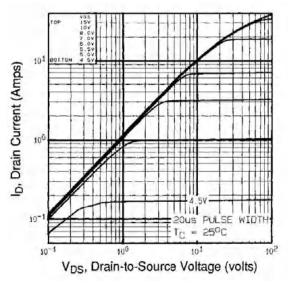


THERMAL RESISTANCE RATII	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		40				
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	0.24 -				°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.65						
SPECIFICATIONS ($T_J = 25 \text{ °C}$, u		1			-	T	T	I.
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static		1						1
Drain-Source Breakdown Voltage	V _{DS}		= 0 V, I _D =		900	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		e to 25 °C,		-	0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D =	250 µA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20$	V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =	= 800 V, V _C	_{as} = 0 V	-	-	100	μA
	280י	$V_{DS} = 640 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$		-	-	500	μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$			-	2.7	-	Ω
Forward Transconductance	g fs	$V_{DS} =$: 100 V, I _D :	= 1.7 A ^b	5.6	-	-	S
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 V$	1	-	1800	-	
Output Capacitance	C _{oss}	$V_{\text{DS}} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	500	-	pF	
Reverse Transfer Capacitance	C _{rss}			-	290	-		
Total Gate Charge	Qg				-	-	200	nC
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$		A, $V_{DS} = 400 V$, ig. 6 and 13 ^b	-	-	24	
Gate-Drain Charge	Q _{gd}		0001	ig. o and to	-	-	110	
Turn-On Delay Time	t _{d(on)}				-	19	-	- ns
Rise Time	tr		= 400 V, I _D		-	38	-	
Turn-Off Delay Time	t _{d(off)}	R _g =	= 6.2 Ω, R _D see fig. 10	= 52 Ω nb	-	120	-	
Fall Time	t _f		see lig. It		-	39	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-		
Internal Source Inductance	L _S			-	13	-	nH	
Drain-Source Body Diode Characteristic	S							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	21	A	
Body Diode Voltage	V _{SD}	$T_J = 25 \text{ °C}, I_S = 1.8 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	1.8	V	
Body Diode Reverse Recovery Time	t _{rr}	T.=	25 °C. I⊧ =	: 1.8 A.	-	650	980	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = 1.8 \text{ A},$ dI/dt = 100 A/µs ^b		-	3.8	5.7	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				•		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



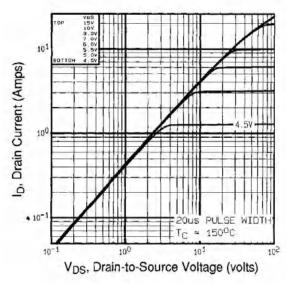


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

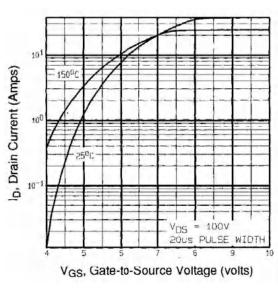
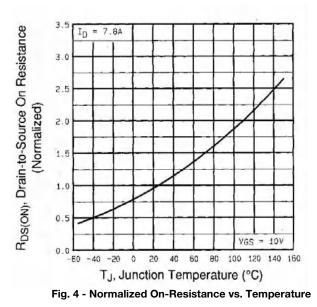


Fig. 3 - Typical Transfer Characteristics



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Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



Fig. 7 - Typical Source-Drain Diode Forward Voltage

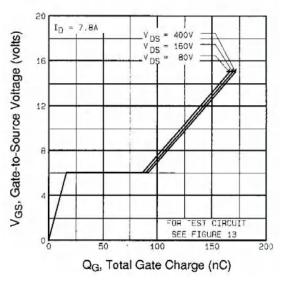
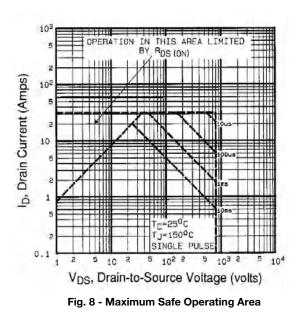


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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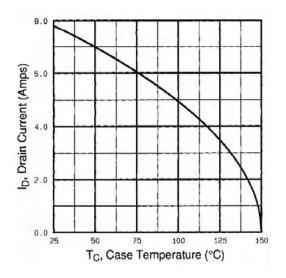


Fig. 9 - Maximum Drain Current vs. Case Temperature

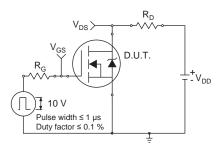


Fig. 10a - Switching Time Test Circuit

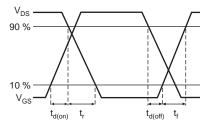


Fig. 10b - Switching Time Waveforms

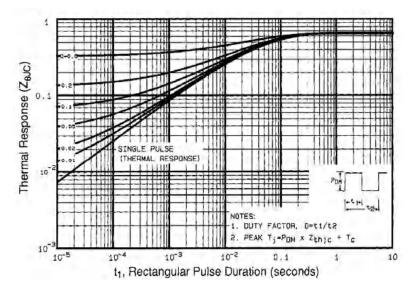


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



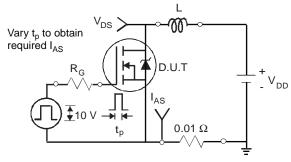


Fig. 12a - Unclamped Inductive Test Circuit



Fig. 12b - Unclamped Inductive Waveforms

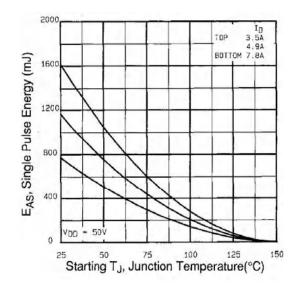


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



Fig. 13a - Basic Gate Charge Waveform

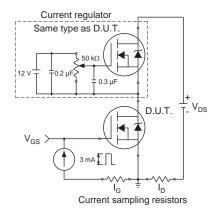
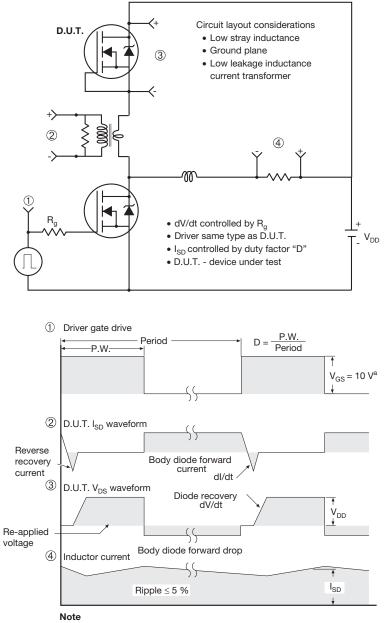


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

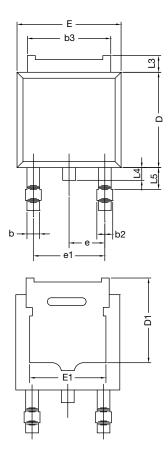


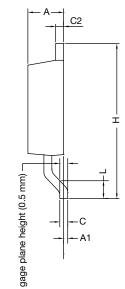
a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-252AA CASE OUTLINE





	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
E	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28 BSC		0.090 BSC		
e1	4.56	BSC	0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

Note

• Dimension L3 is for reference only.



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